

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:	MICHAELSEN, Carsten et al.	) Examiner:
Application No.:	unknown	) unknown
Filing Date:	unknown	) Art Unit:
For:	REFLECTOR FOR X-RAY RADIATION	) unknown

Atty. Docket No.: P8073US

Commissioner for Patents  
Alexandria, VA 22313-1450

U.S.A.

**INFORMATION DISCLOSURE STATEMENT**

The Examiner is referred to the List of Prior Art (Form PTO-1449A).

DE 44 07 278 is described on pages 1 and 2 of the instant specification,  
Handbuch der Physik on page 17, DE 197 01 419 on page 22, and  
DE 199 35 513 on page 29.



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Dr. Paul Vincent  
Reg. No. 37,461

Kohler Schmid & Partner  
Patentanwälte  
Ruppmannstrasse 27  
D-70565 Stuttgart  
Germany  
Telephone: 49-711-78 47 30  
Fax : 49-711-78 00 996

Enclosures:  
PTO-Form 1449 (2 pages)  
Copies of cited references

Substitute for form 1449A/PTO  <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (Use as many sheets as necessary)				<b>Complete if Known</b>	
				Application Number	
				Filing Date	
				First Named Inventor	
				Group Art Unit	
				MICHAELSEN, Carsten et al.	
				Examiner Name	
Sheet 1 of 2				Attorney Docket Number P8073US	

U.S. PATENT DOCUMENTS						
Examiner Initials	Cite No.	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines Where Relevant Passage or Relevant Figure Appear
		Number	Kind Code			
		6 226 349		Schuster	05.01.2001	
		4 525 853		Keem	06.25.1985	
		4 951 304		Piestrup	08.21.1990	
		5 222 113		Thieme	06.22.1993	
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FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No.	Foreign Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
		Office Number	Kind Code			
		DE	44 07 278	Goebel	09.07.1995	
		WO	01/38 861	Loxley	05.31.2001	
		DE	197 01 419	Wulf	07.23.1998	
		DE	199 35 513	Domann	07.26.2001	

Examiner Signature		Date Considered	
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Substitute for form 1449B/PTO				Complete if Known	
<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (Use as many sheets as necessary)				Application Number	
				Filing Date	
				First Named Inventor	MICHAELSEN, Carsten et al
				Group Art Unit	
				Examiner Name	
Sheet	2	of	2	Attorney Docket Number	P8073US

OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s). publisher, city and/or country where published	T
		M. Schuster et al., "Laterally Graded Multilayer Optics for X-Ray Analysis", SPIE, Denver, 199, p. 183 ff	
		M. Montel et al., "X-Ray Microscopy and Micro Radiography, Academic Press, New York, 1957, p. 177-185	
		V.E. Cosslett et al., "X-Ray Microscopy", Cambridge Press, 1960, p. 180 ff	
		S. Fluegge, "Handbuch der Physik", Vol. XXX, Springer Verlag, Berlin, 1957, p. 325 ff	

Examiner Signature		Date Considered	
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